

ELECTRONIC INFORMATION DISCLOSURE STATEMENT

Electronic Version v18

Stylesheet Version v18.0

Title of Invention

METHOD AND APPARATUS FOR AMPLITUDE FILTERING IN
THE FREQUENCY PLANE OF A LITHOGRAPHIC PROJECTION
SYSTEM

Application Number :

10/604,519

Confirmation Number:

First Named Applicant:

Shahid Butt

Attorney Docket Number:

FIS920030150

Art Unit:

Examiner:

Search string:

(5863712).pn

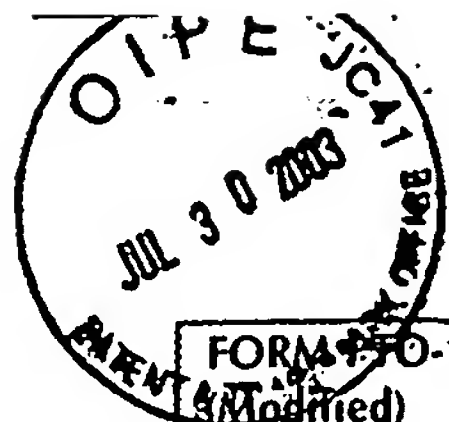
US Patent Documents

Note: Applicant is not required to submit a paper copy of cited US Patent Documents

init	Cite.No.	Patent No.	Date	Patentee	Kind	Class	Subclass
	1	5863712	1999-01-26	Von Bunau et al.			

Signature

Examiner Name	Date
Alan Mathews	1-23-2005

Sheet 1 of 1

FORM PTO-1449 (Modified)	U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE	ATTY. DOCKET NO.: FIS920030150US1	SERIAL NO.: 10/604,519
SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT BY APPLICANT		APPLICANT: Shabid Butt et al.	
(Use several sheets if necessary) (37 CFR 1.98(b))		FILING DATE: July 28, 2003	GROUP:

REFERENCE DESIGNATION

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		PATENT NUMBER	ISSUE DATE	PATENTEE	CLASS	SUB- CLASS	FILING DATE IF APPROPRIATE
	AA						
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	PUBLICATION DATE	COUNTRY OR PATENT OFFICE	CLASS	SUB- CLASS	TRANSLATION	
							YES	NO
	AL							
	AM							
	AN							
	AO							
	AP							

OTHER ART (Including Author, Title, Date, Pertinent Pages, etc.)

AM	AQ	"Characterization of Super-Resolution Photolithography", H. Fukuda, R. Yamanaka, T. Terasawa, K. Hama, T. Tawa and S. Okazaki, IEEE, 4/1992, pages 3.2.1-3.2.4.
AN	AR	"Resolution Enhancement by Oblique Illumination Optical Lithography Using a Pupil Filter", T. Horiuchi, Y. Takeuchi, S. Matsuo and K. Harada, IEEE, 1993, pages 27.3.1-27.3.4
	AS	
EXAMINER Alan Mathews		DATE CONSIDERED 1-23-2005

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in c nformance and not considered. Include copy of this form with next communication to applicant.